Notice of References Cited Application/Control No. 10/051,861 Examiner Nicholas Martin Applicant(s)/Patent Under Reexamination LUO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0010865	01-2002	FULTON et al.	709/229
	В	US-2002/0075844	06-2002	Hagen, W. Alexander	370/351
	O	US-6,765,881	07-2004	Rajakarunanayake, Yasantha N.	370/256
	۵	US-6,606,744	08-2003	Mikurak, Michael G.	717/174
	ш	US-6,016,318	01-2000	Tomoike, Hiroyuki	709/249
	L	US-2002/0069278	06-2002	Forslow, Jan	709/229
	G	US-			
	т	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р	•					
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
	٧	
	w	
٠	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.